

# PMZ600UNE

20 V, N-channel Trench MOSFET

26 June 2014

## 1. General description

N-channel enhancement mode Field-Effect Transistor (FET) in a leadless ultra small DFN1006-3 (SOT883) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

## 2. Features and benefits

- Trench MOSFET technology
- Leadless ultra small SMD plastic package:  $1.0 \times 0.6 \times 0.48$  mm
- ElectroStatic Discharge (ESD) protection > 1 kV HBM
- Drain-source on-state resistance  $R_{DSon} = 470$  mΩ

## 3. Applications

- Relay driver
- High-speed line driver
- Low-side load switch
- Switching circuits

## 4. Quick reference data

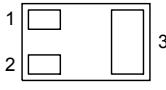
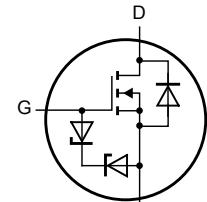
Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
$V_{DS}$	drain-source voltage	$T_j = 25^\circ\text{C}$		-	-	20	V
$V_{GS}$	gate-source voltage			-8	-	8	V
$I_D$	drain current	$V_{GS} = 4.5$ V; $T_{amb} = 25^\circ\text{C}$	[1]	-	-	0.6	A
<b>Static characteristics</b>							
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 4.5$ V; $I_D = 0.6$ A; $T_j = 25^\circ\text{C}$		-	470	620	mΩ

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.

## 5. Pinning information

**Table 2.** Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	S	source		
3	D	drain	 Transparent top view <b>DFN1006-3 (SOT883)</b>	 017aaa255

## 6. Ordering information

**Table 3.** Ordering information

Type number	Package		
	Name	Description	Version
PMZ600UNE	DFN1006-3	DFN1006-3: leadless ultra small plastic package; 3 solder lands	SOT883

## 7. Marking

**Table 4.** Marking codes

Type number	Marking code
PMZ600UNE	SA

## 8. Limiting values

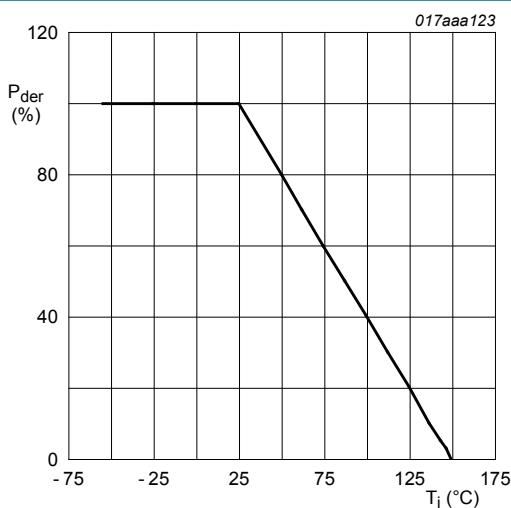
**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
$V_{DS}$	drain-source voltage	$T_j = 25^\circ\text{C}$	-	-	20	V
$V_{GS}$	gate-source voltage		-8	8	V	
$I_D$	drain current	$V_{GS} = 4.5 \text{ V}; T_{amb} = 25^\circ\text{C}$	[1]	-	0.6	A
		$V_{GS} = 4.5 \text{ V}; T_{amb} = 100^\circ\text{C}$	[1]	-	0.4	A
$I_{DM}$	peak drain current	$T_{amb} = 25^\circ\text{C}$ ; single pulse; $t_p \leq 10 \mu\text{s}$	-	-	2.5	A
$P_{tot}$	total power dissipation	$T_{amb} = 25^\circ\text{C}$	[2]	-	360	mW
		$T_{sp} = 25^\circ\text{C}$	[1]	-	715	mW
			-	-	2700	mW
$T_j$	junction temperature		-	-55	150	°C
$T_{amb}$	ambient temperature		-	-55	150	°C
$T_{stg}$	storage temperature		-	-65	150	°C
<b>Source-drain diode</b>						
$I_S$	source current	$T_{amb} = 25^\circ\text{C}$	[1]	-	0.4	A

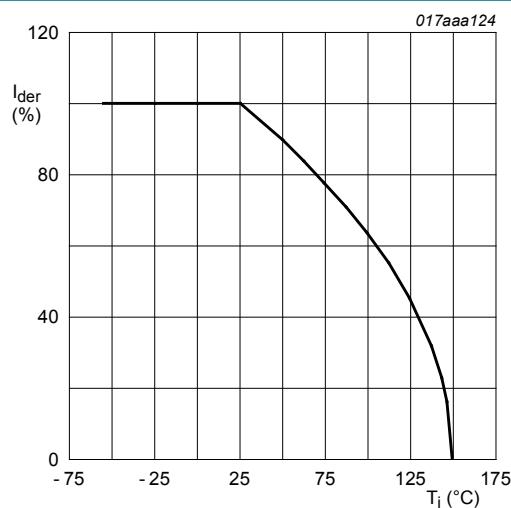
[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain  $1 \text{ cm}^2$ .

[2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.



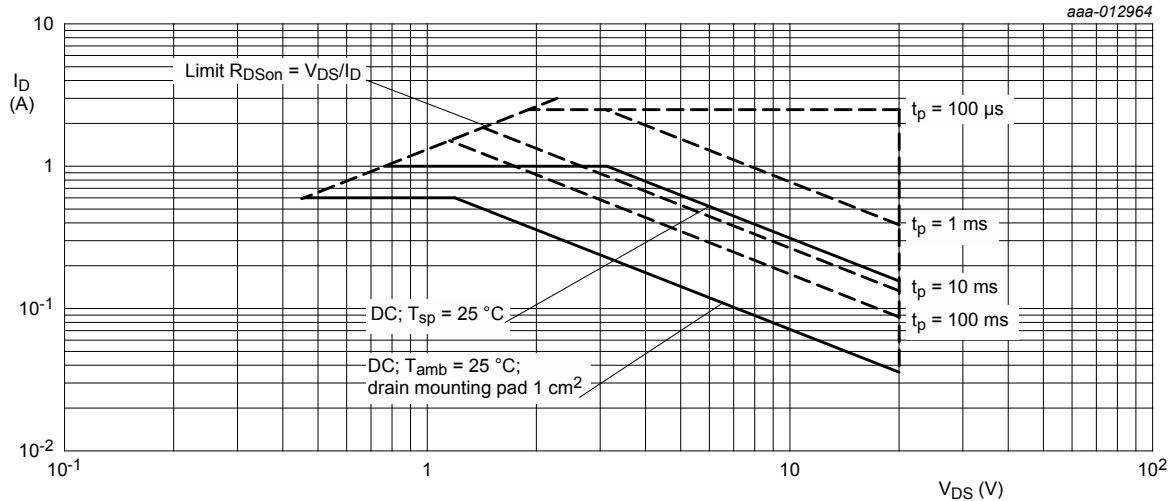
**Fig. 1. Normalized total power dissipation as a function of junction temperature**

$$P_{der} = \frac{P_{tot}}{P_{tot}(25^\circ\text{C})} \times 100 \%$$



**Fig. 2. Normalized continuous drain current as a function of junction temperature**

$$I_{der} = \frac{I_D}{I_D(25^\circ\text{C})} \times 100 \%$$



**Fig. 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage**

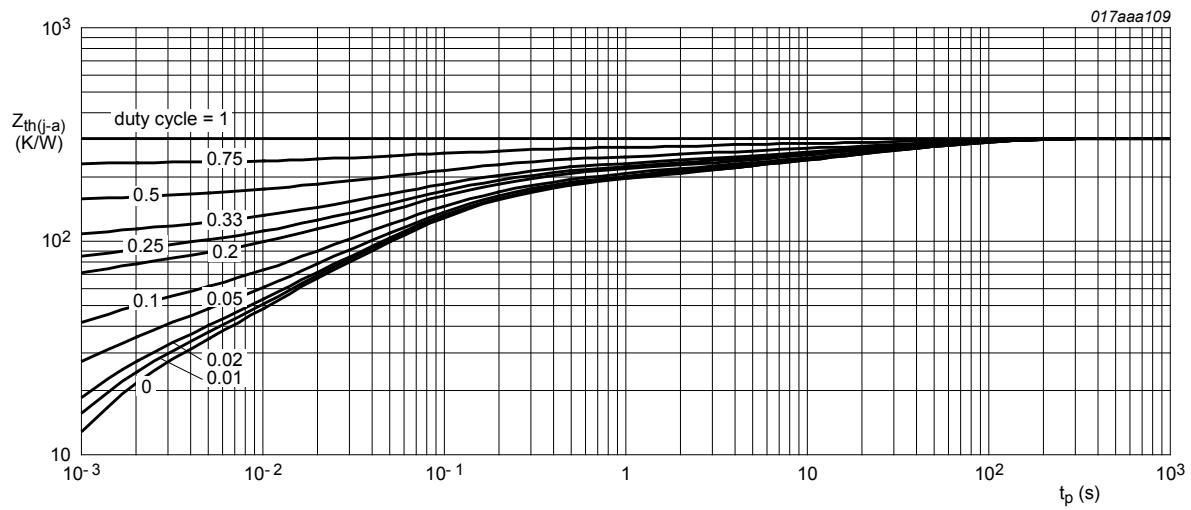
## 9. Thermal characteristics

**Table 6. Thermal characteristics**

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[1]	-	305	360	K/W
			[2]	-	150	175	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point			-	-	40	K/W

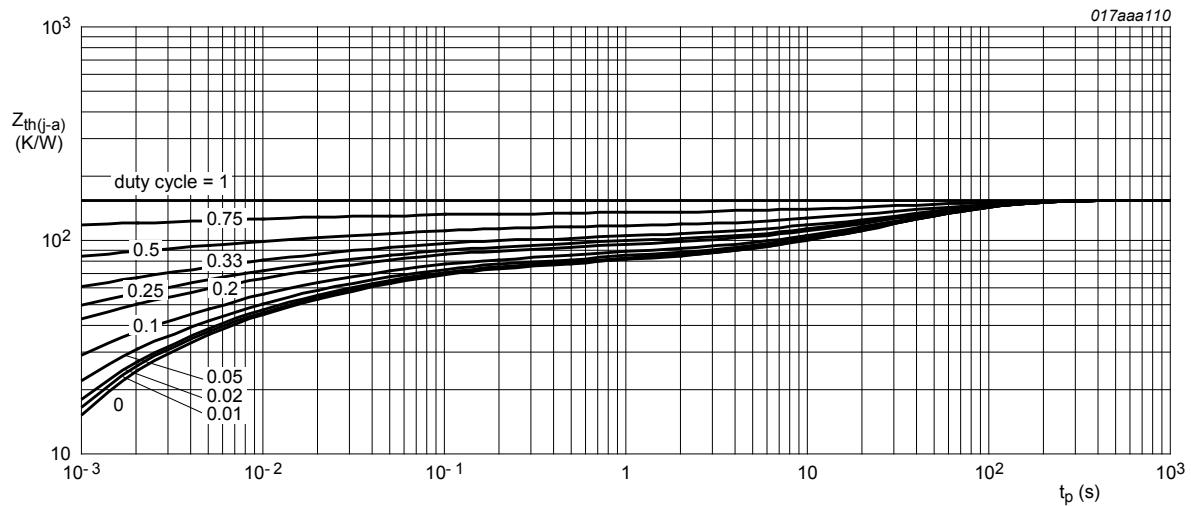
[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.



FR4 PCB, standard footprint

**Fig. 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**



FR4 PCB, mounting pad for drain  $1 \text{ cm}^2$

**Fig. 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**

## 10. Characteristics

**Table 7. Characteristics**

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
<b>Static characteristics</b>							
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25^\circ C$		20	-	-	V
$V_{GSth}$	gate-source threshold voltage	$I_D = 250 \mu A; V_{DS} = V_{GS}; T_j = 25^\circ C$		0.45	0.7	0.95	V
$I_{DSS}$	drain leakage current	$V_{DS} = 20 V; V_{GS} = 0 V; T_j = 25^\circ C$		-	-	1	$\mu A$
		$V_{DS} = 20 V; V_{GS} = 0 V; T_j = 150^\circ C$		-	-	10	$\mu A$
$I_{GSS}$	gate leakage current	$V_{GS} = 8 V; V_{DS} = 0 V; T_j = 25^\circ C$		-	-	10	$\mu A$
		$V_{GS} = -8 V; V_{DS} = 0 V; T_j = 25^\circ C$		-	-	-10	$\mu A$
		$V_{GS} = 4.5 V; V_{DS} = 0 V; T_j = 25^\circ C$		-	-	1	$\mu A$
		$V_{GS} = -4.5 V; V_{DS} = 0 V; T_j = 25^\circ C$		-	-	-1	$\mu A$
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 4.5 V; I_D = 0.6 A; T_j = 25^\circ C$		-	470	620	$m\Omega$
		$V_{GS} = 4.5 V; I_D = 0.6 A; T_j = 150^\circ C$		-	760	1000	$m\Omega$
		$V_{GS} = 2.5 V; I_D = 0.5 A; T_j = 25^\circ C$		-	620	850	$m\Omega$
		$V_{GS} = 1.8 V; I_D = 0.1 A; T_j = 25^\circ C$		-	845	1300	$m\Omega$
		$V_{GS} = 1.5 V; I_D = 10 mA; T_j = 25^\circ C$		-	1125	3000	$m\Omega$
		$V_{GS} = 1.2 V; I_D = 1 mA; T_j = 25^\circ C$		-	2210	-	$m\Omega$
$g_{fs}$	forward transconductance	$V_{DS} = 5 V; I_D = 0.6 A; T_j = 25^\circ C$		-	1	-	S
$R_G$	gate resistance	$f = 1 MHz$		-	34	-	$\Omega$
<b>Dynamic characteristics</b>							
$Q_{G(tot)}$	total gate charge	$V_{DS} = 10 V; I_D = 0.6 A; V_{GS} = 4.5 V; T_j = 25^\circ C$		-	0.4	0.7	nC
$Q_{GS}$	gate-source charge			-	0.1	-	nC
$Q_{GD}$	gate-drain charge			-	0.1	-	nC
$C_{iss}$	input capacitance	$V_{DS} = 10 V; f = 1 MHz; V_{GS} = 0 V; T_j = 25^\circ C$		-	21.3	-	pF
$C_{oss}$	output capacitance			-	5.4	-	pF
$C_{rss}$	reverse transfer capacitance			-	4.2	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = 10 V; I_D = 0.6 A; V_{GS} = 4.5 V; R_{G(ext)} = 6 \Omega; T_j = 25^\circ C$		-	5.6	-	ns
$t_r$	rise time			-	9.2	-	ns
$t_{d(off)}$	turn-off delay time			-	19	-	ns
$t_f$	fall time			-	51	-	ns

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
<b>Source-drain diode</b>							
$V_{SD}$	source-drain voltage	$I_S = 0.36 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$		-	0.8	1.2	V

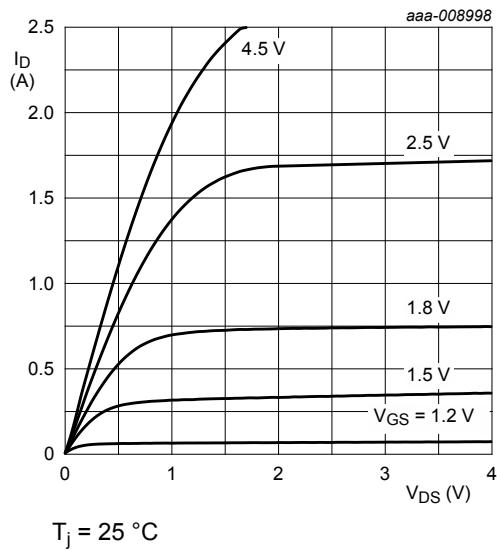


Fig. 6. Output characteristics: drain current as a function of drain-source voltage; typical values

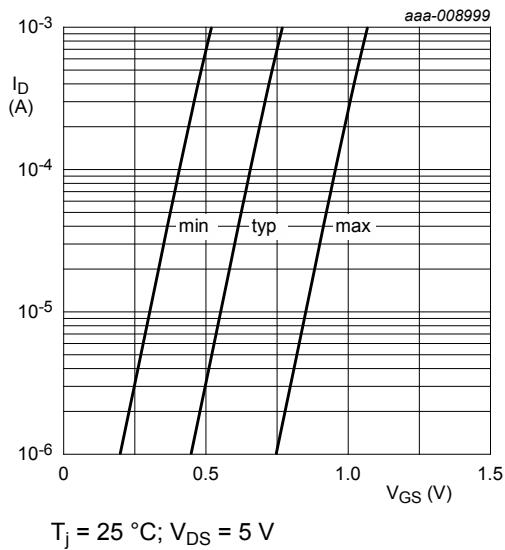


Fig. 7. Sub-threshold drain current as a function of gate-source voltage

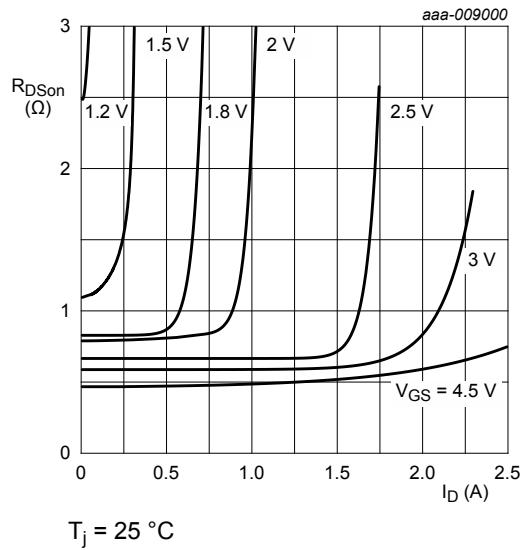


Fig. 8. Drain-source on-state resistance as a function of drain current; typical values

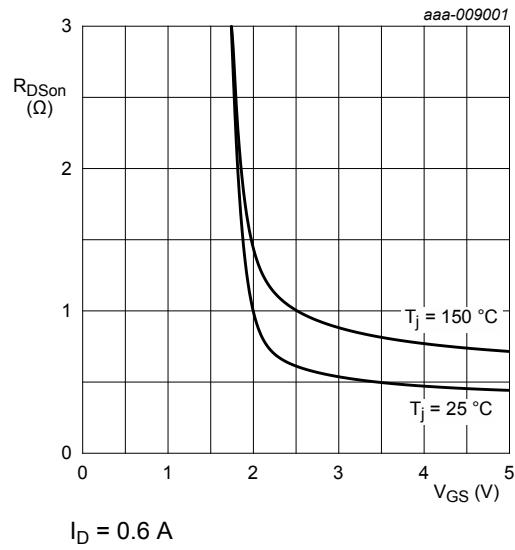
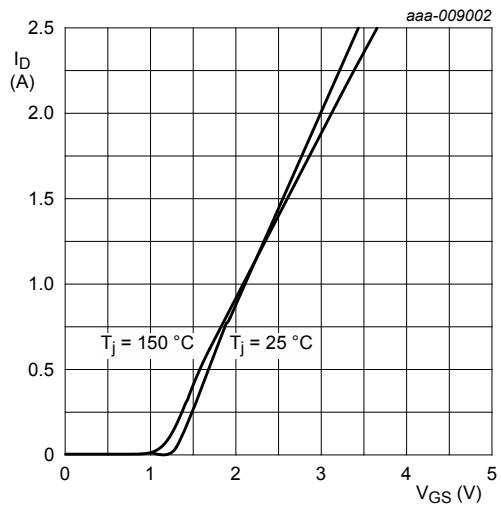
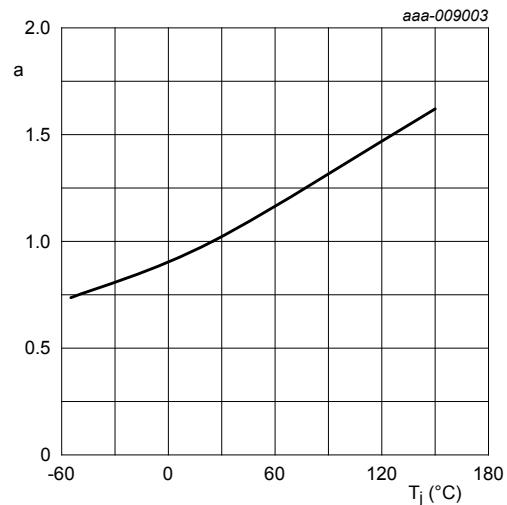


Fig. 9. Drain-source on-state resistance as a function of gate-source voltage; typical values



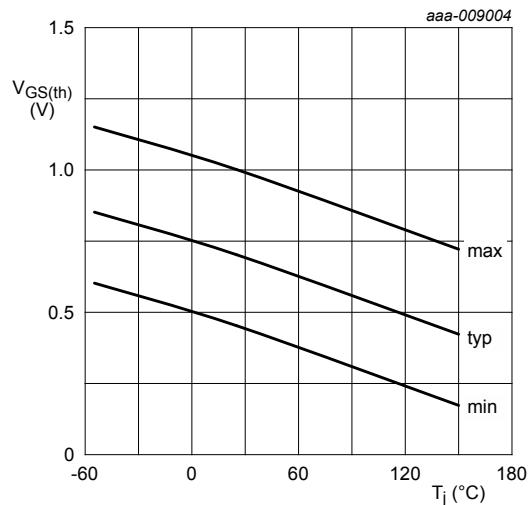
$V_{DS} > I_D \times R_{DSon}$

**Fig. 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values**



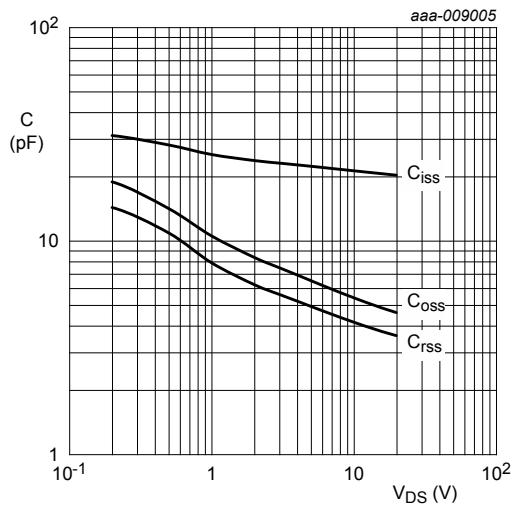
**Fig. 11. Normalized drain-source on-state resistance as a function of junction temperature; typical values**

$$a = \frac{R_{DSon}}{R_{DSon}(25^\circ\text{C})}$$



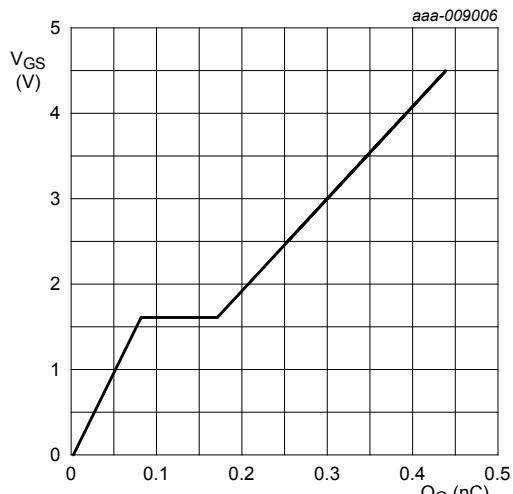
$I_D = 0.25 \text{ mA}; V_{DS} = V_{GS}$

**Fig. 12. Gate-source threshold voltage as a function of junction temperature**

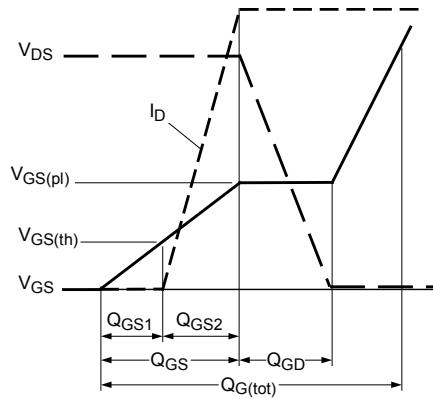


$f = 1 \text{ MHz}; V_{GS} = 0 \text{ V}$

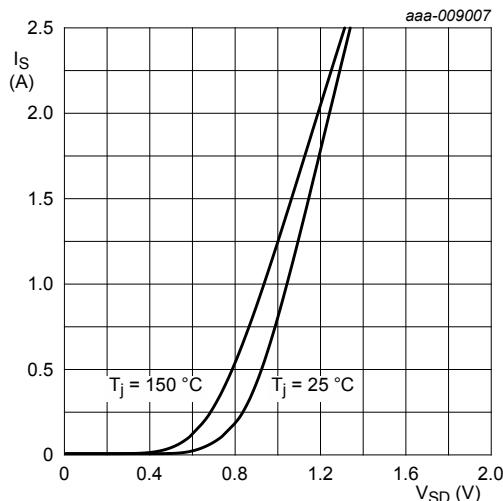
**Fig. 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**



**Fig. 14. Gate-source voltage as a function of gate charge; typical values**

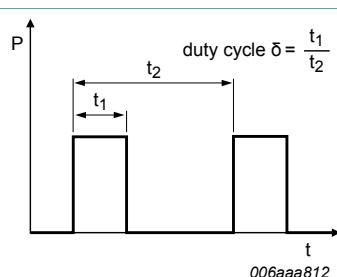


**Fig. 15. MOSFET transistor: Gate charge waveform definitions**



**Fig. 16. Source current as a function of source-drain voltage; typical values**

## 11. Test information



**Fig. 17. Duty cycle definition**

## 12. Package outline

Leadless ultra small plastic package; 3 solder lands; body 1.0 x 0.6 x 0.5 mm

SOT883

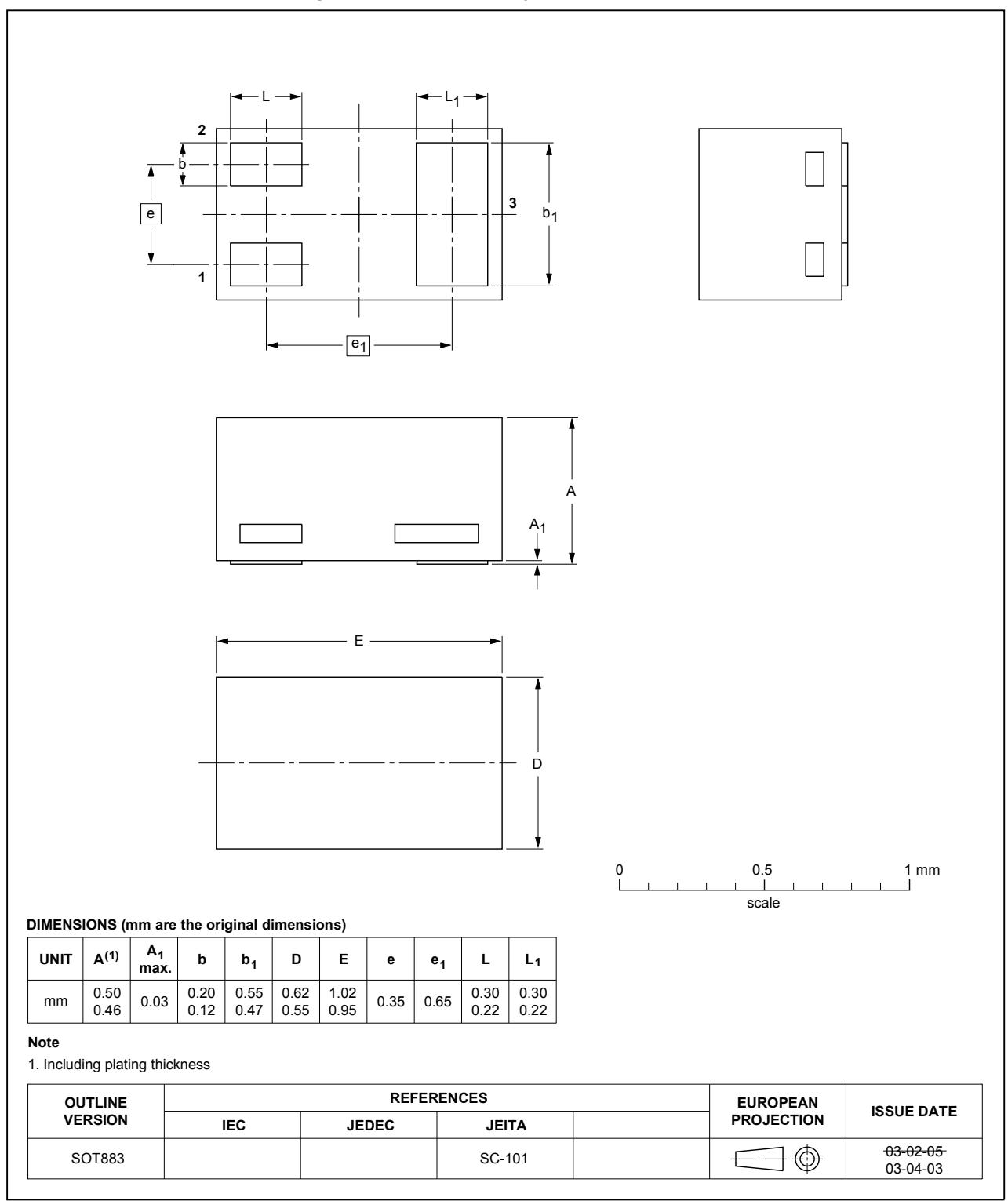
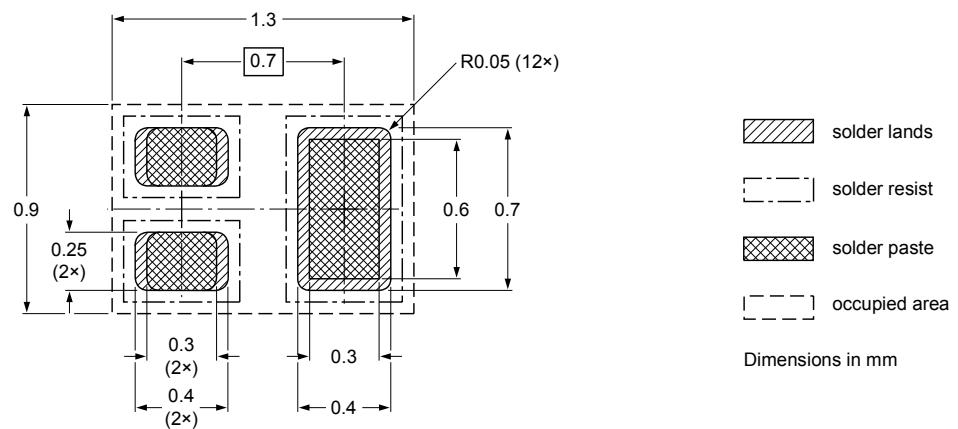


Fig. 18. Package outline DFN1006-3 (SOT883)

## 13. Soldering



sot883\_fr

Fig. 19. Reflow soldering footprint for DFN1006-3 (SOT883)

## 14. Revision history

**Table 8. Revision history**

Data sheet ID	Release date	Data sheet status	Change notice	Supersedes
PMZ600UNE v.2	20140626	Product data sheet	Product data sheet	PMZ600UNE v.1
Modifications:	• Limiting values parameter source current corrected.			
PMZ600UNE v.1	20140509	Product data sheet	-	-

## 15. Legal information

### 15.1 Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

**Nexperia**

**PMZ600UNE**

**20 V, N-channel Trench MOSFET**

## 16. Contents

1	General description .....	1
2	Features and benefits .....	1
3	Applications .....	1
4	Quick reference data .....	1
5	Pinning information .....	2
6	Ordering information .....	2
7	Marking .....	2
8	Limiting values .....	3
9	Thermal characteristics .....	4
10	Characteristics .....	6
11	Test information .....	9
12	Package outline .....	10
13	Soldering .....	11
14	Revision history .....	12
15	Legal information .....	13
15.1	Data sheet status .....	13
15.2	Definitions .....	13
15.3	Disclaimers .....	13
15.4	Trademarks .....	14